## TOSHIBA Bi-CMOS Integrated Circuit Silicon Monolithic

## TB62726ANG,TB62726AFG

## 16-bit Constant-Current LED Driver with Operating Voltage of $3.3-\mathrm{V}$ and $5-\mathrm{V}$

The TB62726A series are comprised of constant-current drivers designed for LEDs and LED displays. The output current value can be set using an external resistor.
As a result, all outputs will have virtually the same current levels.
This driver incorporates 16 -bit constant-current outputs, a 16 -bit shift register, a 16 -bit latch and a 16 -bit AND-gate circuit.
These drivers have been designed using the Bi-CMOS process.
The suffix ( $G$ ) appended to the part number represents a Lead $(\mathrm{Pb})$-Free product.

## Features

- Output current capability and number of outputs: $90 \mathrm{~mA} \times 16$ outputs
- Constant current range: 2 to 90 mA
- Application output voltage: 0.7 V (output current 2 to 80 mA )

$$
0.4 \mathrm{~V} \text { (output current } 2 \text { to } 40 \mathrm{~mA} \text { ) }
$$

- For anode-common LEDs
- Input signal voltage levelः $3.3-\mathrm{V}$ and $5-\mathrm{V}$ CMOS level (Schmitt trigger input)
- Power supply voltage range $\mathrm{V}_{\mathrm{DD}}=3.0$ to 5.5 V


SDIP24-P-300-1.78
TB62726AFG


SSOP24-P-300-1.00B
Weight
SDIP24-P-300-1.78: 1.22 g (typ.)
SSOP24-P-300-1.00B: 0.32 g (typ.)

- Maximum output terminal voltage: 17 V
- Serial and parallel data transfer rate: 20 MHz (max, cascade connection)
- Operating temperature range $\mathrm{T}_{\mathrm{opr}}=-40$ to $85^{\circ} \mathrm{C}$
- Package: Type ANG: SDIP24-P-300-1.78

Type AFG: SSOP24-P-300-1.00B

- Current accuracy (All output ON)

| Output Voltage | Current Accuracy |  | Output Current |
| :---: | :---: | :---: | :---: |
|  | Between Bits | Between ICs |  |
| $\geqq 0.4 \mathrm{~V}$ | $\pm 4 \%$ | $\pm 15 \%$ | 2 to 5 mA |
|  |  | $\pm 12 \%$ | 5 to 80 mA |

## Pin Assignment (top view)



Warnings: Short-circuiting an output terminal to GND or to the power supply terminal may broken the device. Please take care when wiring the output terminals, the power supply terminal and the GND terminals.

## Block Diagram



## Truth Table

| CLOCK | $\overline{\text { LATCH }}$ | $\overline{\text { ENABLE }}$ | SERIAL-IN | $\overline{\text { OUT0 }} \cdots \overline{\text { OUT7 }} \cdots \overline{\text { OUT15 }}$ | SERIAL-OUT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\boldsymbol{\sim}$ | H | L | Dn | Dn $\cdots$ Dn $-7 \cdots$ Dn -15 | $\mathrm{Dn}-15$ |
| $\boldsymbol{\sim}$ | L | L | $\mathrm{Dn}+1$ | No change | $\mathrm{Dn}-14$ |
| $\boldsymbol{\sim}$ | H | L | $\mathrm{Dn}+2$ | $\mathrm{Dn}+2 \cdots \mathrm{Dn}-5 \cdots \mathrm{Dn}-13$ | $\mathrm{Dn}-13$ |
| $\square \boldsymbol{\mathrm { q }}$ | X | L | $\mathrm{Dn}+3$ | $\mathrm{Dn}+2 \cdots \mathrm{Dn}-5 \cdots \mathrm{Dn}-13$ | $\mathrm{Dn}-13$ |
| $\downarrow$ | X | H | $\mathrm{Dn}+3$ | OFF | $\mathrm{Dn}-13$ |

Note 1: $\overline{\text { OUT0 }}$ to $\overline{\text { OUT15 }}=$ On when $\mathrm{Dn}=\mathrm{H} ; \overline{\text { OUT0 }}$ to $\overline{\text { OUT15 }}=$ Off when Dn $=\mathrm{L}$.
In order to ensure that the level of the power supply voltage is correct, an external resistor must be connected between R-EXT and GND.

Timing Diagram


Warning: Latch circuit is leveled-latch circuit. Be careful because it is not triggered-latch circuit.
Note 2: The latches circuit holds data by pulling the $\overline{\text { LATCH }}$ terminal Low.
And, when $\overline{\text { LATCH }}$ terminal is a High level, latch circuit doesn't hold data, and it passes from the input to the output.
When $\overline{\text { ENABLE }}$ terminal is a Low level, output terminal $\overline{\text { OUTO }}$ to $\overline{\text { OUT15 }}$ respond to the data, and on and off does.
And, when ENABLE terminal is a High level, it offs with the output terminal regardless of the data.

## Terminal Description

| Pin No. | Pin Name |  |
| :---: | :---: | :--- |
| 1 | GND | GND terminal for control logic |
| 2 | SERIAL-IN | Input terminal for serial data for data shift register |
| 3 | $\overline{\text { CLOCK }}$ | Input terminal for clock for data shift on rising edge |
| 4 | $\overline{\text { LATCH }}$ | Input terminal for data strobe <br> When the $\overline{\text { LATCH }}$ input is driven High, data is not latched. When it is pulled Low, data is <br> latched. |
| 5 to 20 | $\overline{\text { OUTO }}$ to $\overline{\text { OUT15 }}$ | Constant-current output terminals |
| 21 | $\overline{\text { ENABLE }}$ | Input terminal for output enable. <br> All outputs ( $\overline{\text { OUTO }}$ to $\overline{\text { OUT15 }) ~ a r e ~ t u r n e d ~ o f f, ~ w h e n ~ t h e ~} \overline{\text { ENABLE }}$ terminal is driven High. <br> And are turned on, when the terminal is driven Low. |
| 22 | SERIAL-OUT | Output terminal for serial data input on SERIAL-IN terminal |
| 23 | R-EXT | Input terminal used to connect an external resistor. This regulated the output current. |
| 24 | VDD | $3.3-\mathrm{V} / 5-\mathrm{V}$ supply voltage terminal |

## Equivalent Circuits for Inputs and Outputs

1. ENABLE terminal

2. CLOCK, SERIAL-IN terminal

3. $\overline{\mathrm{OUTO}}$ to $\overline{\mathrm{OUT} 15}$ terminals


## 2. LATCH terminal


4. SERIAL-OUT terminal


Absolute Maximum Ratings ( $\mathrm{T}_{\mathrm{opr}}=25^{\circ} \mathrm{C}$ )

| Characteristics |  | Symbol | Rating |
| :--- | :---: | :---: | :---: | Unit

Note 3: ANG-Type: Powers dissipation is derated by $14.28 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ if device is mounted on PCB and ambient temperature is above $25^{\circ} \mathrm{C}$.
AFG-Type: Powers dissipation is derated by $6.67 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ if device is mounted on PCB and ambient temperature is above $25^{\circ} \mathrm{C}$.

With device mounted on glass-epoxy PCB of less than $40 \% \mathrm{Cu}$ and of dimensions
$50 \mathrm{~mm} \times 50 \mathrm{~mm} \times 1.6 \mathrm{~mm}$.
Recommended Operating Conditions ( $\mathrm{T}_{\mathrm{opr}}=-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ unless otherwise specified)

| Characteristics | Symbol | Conditions | Min | Typ. | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Supply voltage | $V_{\text {DD }}$ | - | 3 | - | 5.5 | V |
| Output voltage | V OUT | - | - | 0.7 | 4 | $\checkmark$ |
| Output current | Iout | Each DC 1 circuit | 2 | - | 80 | $\mathrm{mA} / \mathrm{ch}$ |
|  | IOH | SERIAL-OUT | - | - | -1 | mA |
|  | lOL | SERIAL-OUT | - | - | 1 |  |
| Inp | $\mathrm{V}_{\mathrm{IH}}$ | - | $\begin{aligned} & 0.7 \times \\ & V_{D D} \end{aligned}$ | - | $\begin{gathered} \mathrm{V}_{\mathrm{DD}}+ \\ 0.15 \end{gathered}$ | V |
|  | VIL |  | -0.15 | - | $\begin{aligned} & 0.3 \times \\ & V_{D D} \end{aligned}$ |  |
| Clock frequency | $\mathrm{f}_{\text {CLK }}$ | Cascade connected | - | - | 20 | MHz |
| $\overline{\text { LATCH }}$ pulse width | $\mathrm{t}_{\text {wLAT }}$ |  | 50 | - | - | ns |
| CLOCK pulse width | $\mathrm{t}_{\mathrm{wCLK}}$ | - | 25 | - | - | ns |
| ENABLE pulse width(Note 4) | $\mathrm{t}_{\mathrm{w}}$ ENA | Upper I ${ }_{\text {OUT }}=20 \mathrm{~mA}$ | 2000 | - | - | ns |
|  |  | Lower IOUT $=20 \mathrm{~mA}$ | 3000 | - | - |  |
| Set-up time for CLOCK terminal | tsETUP1 | - | 10 | - | - | ns |
| Hold time for CLOCK terminal | $\mathrm{t}_{\text {HOLD }}$ |  | 10 | - | - | ns |
| Set-up time for $\overline{\text { LATCH }}$ terminal | $\mathrm{t}_{\text {SETUP2 }}$ |  | 50 | - | - | ns |

Note 4: When the pulse of the Low level is inputted to the ENABLE terminal held in the High level.

Electrical Characteristics ( $\mathrm{T}_{\mathrm{opr}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=3.0 \mathrm{~V}$ to 5.5 V unless otherwise specified)

| Characteristics | Symbol | Conditions |  | Min | Typ. | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Supply voltage | $\mathrm{V}_{\mathrm{DD}}$ | Normal operation |  | 3.0 | - | 5.5 | V |
| Output current | Iout1 | $\begin{array}{\|l} \mathrm{V}_{\mathrm{OUT}}=0.4 \mathrm{~V}, \\ \mathrm{~V}_{\mathrm{DD}}=3.3 \mathrm{~V} \end{array}$ | $\mathrm{REXT}=490 \Omega$ | 31.96 | 36.20 | 40.54 | mA |
|  | Iout2 | $\begin{aligned} & \mathrm{V}_{\text {OUT }}=0.4 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{DD}}=5 \mathrm{~V} \end{aligned}$ |  | 31. 59 | 35.90 | 40.20 |  |
|  | Iout3 | $\begin{aligned} & \mathrm{V}_{\mathrm{OUT}}=0.7 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{DD}}=3.3 \mathrm{~V} \end{aligned}$ | $\mathrm{R}_{\text {EXT }}=250 \Omega$ | 63.63 | 72.30 | 80.97 |  |
|  | Iout4 | $\begin{aligned} & \mathrm{V}_{\text {OUT }}=0.7 \mathrm{~V}, \\ & \mathrm{~V}_{\mathrm{DD}}=5 \mathrm{~V} \end{aligned}$ |  | 62.75 | 71.30 | 79.95 |  |
| Output current error between bits | $\Delta_{\text {I }}$ OUT1 | $\mathrm{V}_{\text {OUT }} \geq 0.4 \mathrm{~V}$, All outputs ON | $\mathrm{R}_{\text {EXT }}=490 \Omega$ | - | $\pm 1$ | $\pm 4$ | \% |
|  | $\Delta \mathrm{I}_{\text {OUT2 }}$ | $\mathrm{V}_{\text {OUT }} \geq 0.4 \mathrm{~V}$, All outputs ON | $\mathrm{R}_{\text {EXT }}=250 \Omega$ |  |  |  |  |
| Output leakage current input voltage | Ioz | $\mathrm{V}_{\text {OUT }}=15.0 \mathrm{~V}$ |  | - | - | 1 | $\mu \mathrm{A}$ |
| Input voltage | $\mathrm{V}_{\text {IN }}$ | - |  | $\begin{gathered} 0.7 \\ \mathrm{~V}_{\mathrm{DD}} \end{gathered}$ | - | $V_{\text {DD }}$ | V |
|  |  | - |  | GND | - | $\begin{gathered} 0.3 \\ V_{D D} \end{gathered}$ |  |
| SOUT terminal voltage | VOL | $\mathrm{l}_{\mathrm{OL}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{DD}}=3.3 \mathrm{~V}$ |  | - | - | 0.3 | V |
|  |  | $\mathrm{I}_{\mathrm{OL}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{DD}}=5 \mathrm{~V}$ |  | - | - | 0.3 |  |
|  | $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{IOH}=-1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{DD}}=3.3 \mathrm{~V}$ |  | 3 | - | - |  |
|  |  | $\mathrm{I}_{\mathrm{OH}}=1.0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{DD}}=5 \mathrm{~V}$ |  | 4.7 | - | - |  |
| Output current Supply voltage Regulation | $\% / V_{\text {DD }}$ | When $\mathrm{V}_{\mathrm{DD}}$ is changed 3 V to 5.5 V |  | - | -1 | -5 | \% |
| Pull-up resistor | R (Up) | $\overline{\text { ENABLE }}$ terminal |  | 115 | 230 | 460 | $\mathrm{k} \Omega$ |
| Pull-down resistor | R (Down) | $\overline{\text { LATCH }}$ terminal |  |  |  |  |  |
| Supply current | IDD (OFF) 1 | $\mathrm{V}_{\text {OUT }}=15.0 \mathrm{~V}$ | $\mathrm{R}_{\text {EXT }}=$ OPEN | - | 0.1 | 0.5 | mA |
|  | IDD (OFF) 2 | $\mathrm{V}_{\mathrm{OUT}}=15.0 \mathrm{~V},$ <br> All outputs OFF | $\mathrm{REXT}^{\text {e }}=490 \Omega$ | 1 | 3.5 | 5 |  |
|  | IDD (OFF) 3 | $\mathrm{V}_{\text {OUT }}=15.0 \mathrm{~V}$, <br> All outputs OFF | $\mathrm{REXT}^{\text {e }}=250 \Omega$ | 4 | 6 | 9 |  |
|  | IDD (ON) 1 | $\mathrm{V}_{\text {OUT }}=0.7 \mathrm{~V},$ <br> All outputs ON | $\mathrm{REXT}^{\text {e }}=490 \Omega$ | - | 9 | 15 |  |
|  |  | Same as the above, $\mathrm{T}_{\text {opr }}=-40^{\circ} \mathrm{C}$ |  | - | - | 20 |  |
|  | $\mathrm{I}_{\mathrm{DD}}(\mathrm{ON}) 2$ | $\mathrm{V}_{\text {OUT }}=0.7 \mathrm{~V},$ <br> All outputs ON | $\mathrm{REXT}^{\text {e }}=250 \Omega$ | - | 18 | 25 |  |
|  |  | Same as the above, $\mathrm{T}_{\mathrm{opr}}=-40^{\circ} \mathrm{C}$ |  | - | - | 40 |  |

Switching Characteristics ( $\mathbf{T}_{\text {opr }}=\mathbf{2 5}{ }^{\circ} \mathrm{C}$ unless otherwise specifed)

| Characteristics | Symbol | Conditions | Min | Typ. | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Propagation delay | $t_{\text {pLH1 }}$ | $\begin{aligned} & \overline{\text { CLK- } \overline{\mathrm{OUTn}}}, \overline{\mathrm{LATCH}}=" \mathrm{H} ", \\ & \overline{\mathrm{ENABLE}}=" \mathrm{~L} " \end{aligned}$ | - | 150 | 300 | ns |
|  | $t_{\text {pLH2 }}$ | $\begin{aligned} & \overline{\mathrm{LATCH}}-\overline{\mathrm{OUTn}}, \\ & \overline{\mathrm{ENABLE}}=\text { "L" } \end{aligned}$ | - | 140 | 300 |  |
|  | $\mathrm{t}_{\mathrm{pLH}}$ | $\begin{aligned} & \overline{\overline{\text { ENABLE }}-\overline{\text { OUTn }},} \\ & \overline{\text { LATCH }}=\text { "H" } \end{aligned}$ | - | 140 | 300 |  |
|  | $\mathrm{t}_{\mathrm{pLH}}$ | CLK-SERIAL OUT | 3 | 6 | - |  |
|  | $\mathrm{t}_{\mathrm{pHL}}$ | $\begin{aligned} & \overline{\text { CLK- } \overline{\mathrm{OUTn}}}, \overline{\mathrm{LATCH}}=" \mathrm{H} ", \\ & \text { ENABLE }=" \mathrm{~L} " \end{aligned}$ | - | 170 | 340 |  |
|  | $\mathrm{t}_{\mathrm{pHL}}$ | $\begin{aligned} & \overline{\mathrm{LATCH}}-\overline{\mathrm{OUTn}}, \\ & \overline{\mathrm{ENABLE}}=\text { "L" } \end{aligned}$ | - | 170 | 340 |  |
|  | $\mathrm{t}_{\mathrm{pHL}}$ | $\begin{aligned} & \overline{\text { ENABLE }-\overline{O U T n},} \\ & \overline{\text { LATCH }}=" \mathrm{H} " \end{aligned}$ | - | 170 | 340 |  |
|  | $t_{\text {pLH }}$ | CLK-SERIAL OUT | 4 | 7 | - |  |
| Output rise time | $\mathrm{t}_{\text {or }}$ | 10 to $90 \%$ of voltage waveform | 40 | 85 | 150 | ns |
| Output fall time | $\mathrm{t}_{\text {of }}$ | 90 to $10 \%$ of voltage waveform | 40 | 70 | 150 | ns |
| Maximum CLOCK rise time | $\mathrm{t}_{\mathrm{r}}$ | When not on PCB(Note 5) | - | - | 5 | $\mu \mathrm{s}$ |
| Maximum CLOCK fall time | $\mathrm{t}_{\mathrm{f}}$ |  | - | - | 5 | $\mu \mathrm{S}$ |

Conditions: (Refer to test circuit.)

$$
\begin{aligned}
& \mathrm{T}_{\mathrm{opr}}=25^{\circ} \mathrm{C}, \mathrm{~V}_{\mathrm{DD}}=\mathrm{V}_{\mathrm{IH}}=3.3 \mathrm{~V} \text { and } 5 \mathrm{~V}, \mathrm{~V}_{\mathrm{OUT}}=0.7 \mathrm{~V}, \mathrm{~V}_{\mathrm{IL}}=0 \mathrm{~V}, \mathrm{R}_{\mathrm{EXT}}=490 \Omega, \\
& \mathrm{~V}_{\mathrm{L}}=3.0 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=60 \Omega, \mathrm{C}_{\mathrm{L}}=10.5 \mathrm{pF}
\end{aligned}
$$

Note 5: If the device is connected in a cascade and $t_{r} / t_{f}$ for the waveform is large, it may not be possible to achieve the timing required for data transfer. Please consider the timings carefully.

## Test Circuit



## Timing Waveforms

1. CLOCK, SERIAL-IN, SERIAL-OUT

2. CLOCK, SERIAL-IN, LATCH, ENABLE, OUTn

3. $\overline{\text { OUTn }}$

OUTn


## Output Current - Duty (LEDS turn-on rate)





## Output Current - $\mathrm{R}_{\mathrm{EXT}}$ Resistor


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## Notes

- Operation may become unstable due to the electromagnetic interference caused by the wiring and other phenomena.
To counter this, it is recommended that the IC be situated as close as possible to the LED module.
If overvoltage is caused by inductance between the LED and the output terminals, both the LED and the terminals may suffer damage as a result.
- There is only one GND terminal on this device when the inductance in the GND line and the resistor are large, the device may malfunction due to the GND noise when output switchings by the circuit board pattern and wiring.
To achieve stable operation, it is necessary to connect a resistor between the REXT terminal and the GND line. Fluctuation in the output waveform is likely to occur when the GND line is unstable or when a capacitor (of more than 50 pF ) is used.
Therefore, take care when designing the circuit board pattern layout and the wiring from the controller.
- This application circuit is a reference example and is not guaranteed to work in all conditions. Be sure to check the operation of your circuits.
- This device does not include protection circuits for overvoltage, overcurrent or overtemperature. If protection is necessary, it must be incorporated into the control circuitry.
- The device is likely to be destroyed if a short-circuit occurs between either of the power supply pins and any of the output terminals when designing circuits, pay special attention to the positions of the output terminals and the power supply terminals (VDD and VLED), and to the design of the GND line.


## Package Dimensions



Weight: 1.22 g (typ.)

## Package Dimensions

SSOP24-P-300-1.00B


Weight: 0.32 g (typ.)

## Notes on Contents

## 1. Block Diagrams

Some of the functional blocks, circuits, or constants in the block diagram may be omitted or simplified for explanatory purposes.

## 2. Equivalent Circuits

The equivalent circuit diagrams may be simplified or some parts of them may be omitted for explanatory purposes.

## 3. Timing Charts

Timing charts may be simplified for explanatory purposes.

## 4. Application Circuits

The application circuits shown in this document are provided for reference purposes only. Thorough evaluation is required, especially at the mass production design stage.
Toshiba does not grant any license to any industrial property rights by providing these examples of application circuits.

## 5. Test Circuits

Components in the test circuits are used only to obtain and confirm the device characteristics. These components and circuits are not guaranteed to prevent malfunction or failure from occurring in the application equipment.

## IC Usage Considerations

## Notes on Handling of ICs

(1) The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings. Exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.
(2) Use an appropriate power supply fuse to ensure that a large current does not continuously flow in case of over current and/or IC failure. The IC will fully break down when used under conditions that exceed its absolute maximum ratings, when the wiring is routed improperly or when an abnormal pulse noise occurs from the wiring or load, causing a large current to continuously flow and the breakdown can lead smoke or ignition. To minimize the effects of the flow of a large current in case of breakdown, appropriate settings, such as fuse capacity, fusing time and insertion circuit location, are required.
(3) If your design includes an inductive load such as a motor coil, incorporate a protection circuit into the design to prevent device malfunction or breakdown caused by the current resulting from the inrush current at power ON or the negative current resulting from the back electromotive force at power OFF. IC breakdown may cause injury, smoke or ignition.
Use a stable power supply with ICs with built-in protection functions. If the power supply is unstable, the protection function may not operate, causing IC breakdown. IC breakdown may cause injury, smoke or ignition.
(4) Do not insert devices in the wrong orientation or incorrectly. Make sure that the positive and negative terminals of power supplies are connected properly. Otherwise, the current or power consumption may exceed the absolute maximum rating, and exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.
In addition, do not use any device that is applied the current with inserting in the wrong orientation or incorrectly even just one time.
(5) Carefully select external components (such as inputs and negative feedback capacitors) and load components (such as speakers), for example, power amp and regulator.
If there is a large amount of leakage current such as input or negative feedback condenser, the IC output DC voltage will increase. If this output voltage is connected to a speaker with low input withstand voltage, overcurrent or IC failure can cause smoke or ignition. (The over current can cause smoke or ignition from the IC itself.) In particular, please pay attention when using a Bridge Tied Load (BTL) connection type IC that inputs output DC voltage to a speaker directly.

## Points to Remember on Handling of ICs

(1) Heat Radiation Design

In using an IC with large current flow such as power amp, regulator or driver, please design the device so that heat is appropriately radiated, not to exceed the specified junction temperature ( Tj ) at any time and condition. These ICs generate heat even during normal use. An inadequate IC heat radiation design can lead to decrease in IC life, deterioration of IC characteristics or IC breakdown. In addition, please design the device taking into considerate the effect of IC heat radiation with peripheral components.
(2) Back-EMF

When a motor rotates in the reverse direction, stops or slows down abruptly, a current flow back to the motor's power supply due to the effect of back-EMF. If the current sink capability of the power supply is small, the device's motor power supply and output pins might be exposed to conditions beyond absolute maximum ratings. To avoid this problem, take the effect of back-EMF into consideration in system design.

About solderability, following conditions were confirmed

- Solderability
(1) Use of Sn-37Pb solder Bath
- solder bath temperature $=230^{\circ} \mathrm{C}$
- dipping time $=5$ seconds
- the number of times = once
- use of R-type flux
(2) Use of $\mathrm{Sn}-3.0 \mathrm{Ag}-0.5 \mathrm{Cu}$ solder Bath
- solder bath temperature $=245^{\circ} \mathrm{C}$
- dipping time $=5$ seconds
- the number of times = once
- use of R-type flux


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